# **Quad 2-Input OR Gate**

# **High-Performance Silicon-Gate CMOS**

The MC74HC32A is identical in pinout to the LS32. The device inputs are compatible with Standard CMOS outputs; with pullup resistors, they are compatible with LSTTL outputs.

### **Features**

- Output Drive Capability: 10 LSTTL Loads
- Outputs Directly Interface to CMOS, NMOS and TTL
- Operating Voltage Range: 2.0 to 6.0 V
- Low Input Current: 1 μA
- High Noise Immunity Characteristic of CMOS Devices
- In Compliance With the JEDEC Standard No. 7 A Requirements
- Chip Complexity: 48 FETs or 12 Equivalent Gates
- These Devices are Pb-Free, Halogen Free and are RoHS Compliant



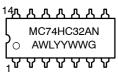
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MARKING DIAGRAMS

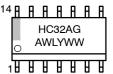


PDIP-14 N SUFFIX CASE 646





SOIC-14 D SUFFIX CASE 751A



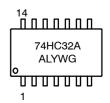


1

TSSOP-14 DT SUFFIX CASE 948G







A = Assembly Location

L, WL = Wafer Lot Y, YY = Year W. WW = Work Week

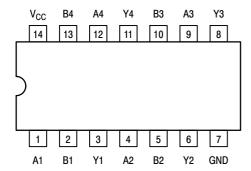
G or ■ = Pb-Free Package

(Note: Microdot may be in either location)

## **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

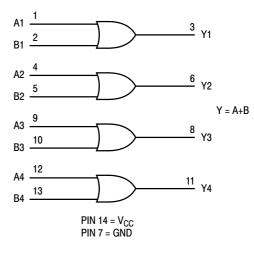
Pinout: 14-Lead Packages (Top View)



# **FUNCTION TABLE**

| Inputs |   | Output |
|--------|---|--------|
| Α      | В | Υ      |
| L      | L | L      |
| L      | Н | Н      |
| Н      | L | Н      |
| Н      | Н | Н      |

# LOGIC DIAGRAM



## **ORDERING INFORMATION**

| Device         | Package                | Shipping <sup>†</sup> |
|----------------|------------------------|-----------------------|
| MC74HC32ANG    | PDIP-14<br>(Pb-Free)   | 25 Units / Rail       |
| MC74HC32ADG    | SOIC-14<br>(Pb-Free)   | 55 Units / Rail       |
| MC74HC32ADR2G  | SOIC-14<br>(Pb-Free)   | 2500 / Tape & Reel    |
| MC74HC32ADTR2G | TSSOP-14*              | 2500 / Tape & Reel    |
| MC74HC32AFELG  | SOEIAJ-14<br>(Pb-Free) | 2500 / Tape & Reel    |

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

<sup>\*</sup>This package is inherently Pb-Free.

### **MAXIMUM RATINGS**

| Symbol           | Parameter   | Value                    | Unit |
|------------------|---|--------------------------|------|
| V <sub>CC</sub>  | DC Supply Voltage (Referenced to GND)   | - 0.5 to + 7.0           | V    |
| V <sub>in</sub>  | DC Input Voltage (Referenced to GND)  | $-0.5$ to $V_{CC}$ + 0.5 | V    |
| V <sub>out</sub> | DC Output Voltage (Referenced to GND)   | $-0.5$ to $V_{CC}$ + 0.5 | V    |
| I <sub>in</sub>  | DC Input Current, per Pin   | ± 20                     | mA   |
| I <sub>out</sub> | DC Output Current, per Pin  | ± 25                     | mA   |
| Icc              | DC Supply Current, V <sub>CC</sub> and GND Pins                                       | ± 50                     | mA   |
| P <sub>D</sub>   | Power Dissipation in Still Air, Plastic DIP† SOIC Package† TSSOP Package†             | 750<br>500<br>450        | mW   |
| T <sub>stg</sub> | Storage Temperature   | - 65 to + 150            | °C   |
| TL               | Lead Temperature, 1 mm from Case for 10 Seconds<br>Plastic DIP, SOIC or TSSOP Package | 260                      | °C   |

This device contains protection circuitry to guard against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to this high-impedance circuit. For proper operation,  $V_{in}$  and  $V_{out}$  should be constrained to the range GND  $\leq$  ( $V_{in}$  or  $V_{out}$ )  $\leq$   $V_{CC}$ .

Unused inputs must always be tied to an appropriate logic voltage level (e.g., either GND or  $V_{CC}$ ). Unused outputs must be left open.

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

†Derating — Plastic DIP: – 10 mW/°C from 65° to 125°C SOIC Package: – 7 mW/°C from 65° to 125°C

TSSOP Package: - 6.1 mW/°C from 65° to 125°C

## RECOMMENDED OPERATING CONDITIONS

| Symbol                             | Parameter   | Min                                      | Max         | Unit               |    |
|------------------------------------|---|--|-------------|--------------------|----|
| V <sub>CC</sub>                    | DC Supply Voltage (Referenced to GND)             | DC Supply Voltage (Referenced to GND)    |             | 6.0                | V  |
| V <sub>in</sub> , V <sub>out</sub> | DC Input Voltage, Output Voltage (Referenced GND) | 1 0 1                                    |             | V <sub>CC</sub>    | V  |
| T <sub>A</sub>                     | Operating Temperature, All Package Types          | Operating Temperature, All Package Types |             | + 125              | °C |
| t <sub>r</sub> , t <sub>f</sub>    | (Figure 1) V <sub>CC</sub> =                      | 2.0 V<br>4.5 V<br>6.0 V                  | 0<br>0<br>0 | 1000<br>500<br>400 | ns |

# DC CHARACTERISTICS (Voltages Referenced to GND)

|                 |   |  |   | v <sub>cc</sub>          | Guara                        | nteed Lin                    | nit                          |      |
|-----------------|---|--|---|--------------------------|------------------------------|------------------------------|------------------------------|------|
| Symbol          | Parameter   | Conditi  | on  | V                        | -55 to 25°C                  | ≤ <b>85°C</b>                | ≤125°C                       | Unit |
| V <sub>IH</sub> | Minimum High-Level Input Voltage                  | $V_{out} = 0.1V \text{ or } V_{CC}$ $ I_{out}  \le 20 \mu A$     | -0.1V   | 2.0<br>3.0<br>4.5<br>6.0 | 1.50<br>2.10<br>3.15<br>4.20 | 1.50<br>2.10<br>3.15<br>4.20 | 1.50<br>2.10<br>3.15<br>4.20 | >    |
| V <sub>IL</sub> | Maximum Low-Level Input Voltage                   | $V_{out} = 0.1V \text{ or } V_{CC}$ $ I_{out}  \le 20 \mu A$     | - 0.1V  | 2.0<br>3.0<br>4.5<br>6.0 | 0.50<br>0.90<br>1.35<br>1.80 | 0.50<br>0.90<br>1.35<br>1.80 | 0.50<br>0.90<br>1.35<br>1.80 | V    |
| V <sub>OH</sub> | Minimum High-Level Output<br>Voltage              | $V_{in} = V_{IH} \text{ or } V_{IL}$<br>$ I_{out}  \le 20 \mu A$ |   | 2.0<br>4.5<br>6.0        | 1.9<br>4.4<br>5.9            | 1.9<br>4.4<br>5.9            | 1.9<br>4.4<br>5.9            | V    |
|                 |   | V <sub>in</sub> =V <sub>IH</sub> or V <sub>IL</sub>              | $\begin{aligned} & \left I_{out}\right  \leq 2.4 \text{mA} \\ & \left I_{out}\right  \leq 4.0 \text{mA} \\ & \left I_{out}\right  \leq 5.2 \text{mA} \end{aligned}$ | 3.0<br>4.5<br>6.0        | 2.48<br>3.98<br>5.48         | 2.34<br>3.84<br>5.34         | 2.20<br>3.70<br>5.20         |      |
| V <sub>OL</sub> | Maximum Low-Level Output<br>Voltage               | $V_{in} = V_{IH} \text{ or } V_{IL}$<br>$ I_{out}  \le 20 \mu A$ |   | 2.0<br>4.5<br>6.0        | 0.1<br>0.1<br>0.1            | 0.1<br>0.1<br>0.1            | 0.1<br>0.1<br>0.1            | ٧    |
|                 |   | $V_{in} = V_{IH}$ or $V_{IL}$                                    | $\begin{aligned} &\left I_{out}\right  \leq 2.4 \text{mA} \\ &\left I_{out}\right  \leq 4.0 \text{mA} \\ &\left I_{out}\right  \leq 5.2 \text{mA} \end{aligned}$    | 3.0<br>4.5<br>6.0        | 0.26<br>0.26<br>0.26         | 0.33<br>0.33<br>0.33         | 0.40<br>0.40<br>0.40         |      |
| l <sub>in</sub> | Maximum Input Leakage Current                     | V <sub>in</sub> = V <sub>CC</sub> or GND                         |   | 6.0                      | ±0.1                         | ±1.0                         | ±1.0                         | μΑ   |
| Icc             | Maximum Quiescent Supply<br>Current (per Package) | $V_{in} = V_{CC}$ or GND $I_{out} = 0\mu A$                      |   | 6.0                      | 1.0                          | 10                           | 40                           | μА   |

# $\label{eq:characteristics} \textbf{AC CHARACTERISTICS} \ (C_L = 50 pF, \ Input \ t_r = t_f = 6 ns)$

|  |   | V <sub>CC</sub>          | Gu                   | aranteed Lim         | nit                   |      |
|--|---|--------------------------|----------------------|----------------------|-----------------------|------|
| Symbol                                 | Parameter   | v                        | -55 to 25°C          | ≤ <b>85°C</b>        | ≤125°C                | Unit |
| t <sub>PLH</sub> ,<br>t <sub>PHL</sub> | Maximum Propagation Delay, Input A or B to Output Y (Figures 1 and 2) | 2.0<br>3.0<br>4.5<br>6.0 | 75<br>30<br>15<br>13 | 95<br>40<br>19<br>16 | 110<br>55<br>22<br>19 | ns   |
| t <sub>TLH</sub> ,<br>t <sub>THL</sub> | Maximum Output Transition Time, Any Output (Figures 1 and 2)          | 2.0<br>3.0<br>4.5<br>6.0 | 75<br>27<br>15<br>13 | 95<br>32<br>19<br>16 | 110<br>36<br>22<br>19 | ns   |
| C <sub>in</sub>                        | Maximum Input Capacitance   |                          | 10                   | 10                   | 10                    | pF   |

|          |   | Typical @ 25°C, V <sub>CC</sub> = 5.0 V, V <sub>EE</sub> = 0 V |    |
|----------|---|--|----|
| $C_{PD}$ | Power Dissipation Capacitance (Per Buffer)* | 20   | pF |

<sup>\*</sup>Used to determine the no–load dynamic power consumption:  $P_D = C_{PD} V_{CC}^2 f + I_{CC} V_{CC}$ .

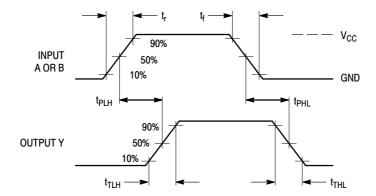
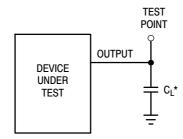


Figure 1. Switching Waveforms



\*Includes all probe and jig capacitance

Figure 2. Test Circuit

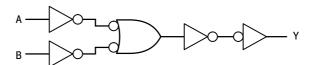
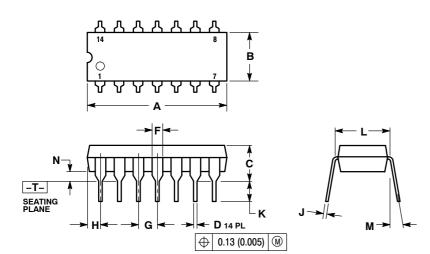


Figure 3. Expanded Logic Diagram (1/4 of the Device)

# **PACKAGE DIMENSIONS**

PDIP-14 **N SUFFIX** CASE 646-06 ISSUE P

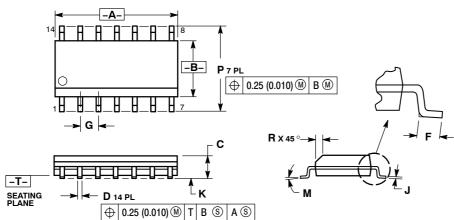


- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.
  3. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL.
  4. DIMENSION B DOES NOT INCLUDE MOLD FLASH.
  5. ROUNDED CORNERS OPTIONAL.

|     | INC   | HES   | MILLIM | IETERS |
|-----|-------|-------|--------|--------|
| DIM | MIN   | MAX   | MIN    | MAX    |
| Α   | 0.715 | 0.770 | 18.16  | 19.56  |
| В   | 0.240 | 0.260 | 6.10   | 6.60   |
| С   | 0.145 | 0.185 | 3.69   | 4.69   |
| D   | 0.015 | 0.021 | 0.38   | 0.53   |
| F   | 0.040 | 0.070 | 1.02   | 1.78   |
| G   | 0.100 | BSC   | 2.54   | BSC    |
| Н   | 0.052 | 0.095 | 1.32   | 2.41   |
| J   | 0.008 | 0.015 | 0.20   | 0.38   |
| K   | 0.115 | 0.135 | 2.92   | 3.43   |
| L   | 0.290 | 0.310 | 7.37   | 7.87   |
| M   |       | 10 °  |        | 10 °   |
| N   | 0.015 | 0.039 | 0.38   | 1.01   |

## **PACKAGE DIMENSIONS**

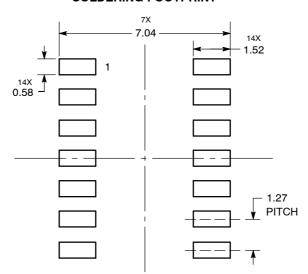
SOIC-14 **D SUFFIX** CASE 751A-03 **ISSUE J** 



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: MILLIMETER.
  3. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION.
  4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
  5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

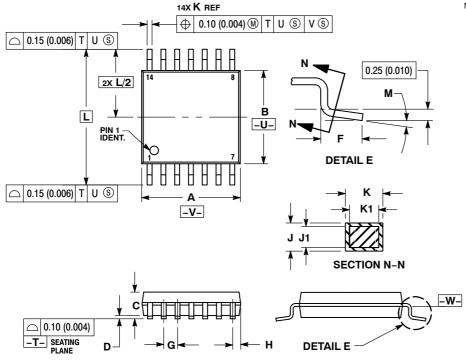
|     | MILLIN   | IETERS | INC   | HES   |
|-----|----------|--------|-------|-------|
| DIM | MIN      | MAX    | MIN   | MAX   |
| Α   | 8.55     | 8.75   | 0.337 | 0.344 |
| В   | 3.80     | 4.00   | 0.150 | 0.157 |
| С   | 1.35     | 1.75   | 0.054 | 0.068 |
| D   | 0.35     | 0.49   | 0.014 | 0.019 |
| F   | 0.40     | 1.25   | 0.016 | 0.049 |
| G   | 1.27 BSC |        | 0.050 | BSC   |
| J   | 0.19     | 0.25   | 0.008 | 0.009 |
| K   | 0.10     | 0.25   | 0.004 | 0.009 |
| М   | 0 °      | 7°     | 0 °   | 7°    |
| Р   | 5.80     | 6.20   | 0.228 | 0.244 |
| R   | 0.25     | 0.50   | 0.010 | 0.019 |

### **SOLDERING FOOTPRINT**



### PACKAGE DIMENSIONS

# TSSOP-14 **DT SUFFIX** CASE 948G-01 ISSUE B



- NOTES:

  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

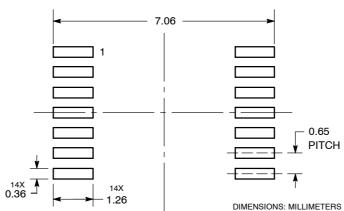
  2. CONTROLLING DIMENSION: MILLIMETER.

  3. DIMENSION A DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
  - DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION.
  - INTERLEAD FLASH OR PROTRUSION.
    INTERLEAD FLASH OR PROTRUSION SHALL
    NOT EXCEED 0.25 (0.010) PER SIDE.
    5. DIMENSION K DOES NOT INCLUDE
    DAMBAR PROTRUSION. ALLOWABLE
    DAMBAR PROTRUSION SHALL BE 0.08
    (0.003) TOTAL IN EXCESS OF THE K
    DIMENSION AT MAXIMUM MATERIAL
    CONDITION.
    6. TERMINAL NUMBERS ARE SHOWN FOR
    REFERENCE ONLY

  - REFERENCE ONLY.
    7. DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE -W-.

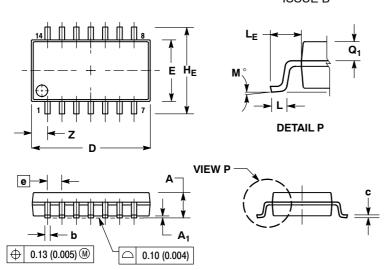
|     | MILLIN   | IETERS | INC   | HES   |
|-----|----------|--------|-------|-------|
| DIM | MIN      | MAX    | MIN   | MAX   |
| Α   | 4.90     | 5.10   | 0.193 | 0.200 |
| В   | 4.30     | 4.50   | 0.169 | 0.177 |
| С   |          | 1.20   |       | 0.047 |
| D   | 0.05     | 0.15   | 0.002 | 0.006 |
| F   | 0.50     | 0.75   | 0.020 | 0.030 |
| G   | 0.65 BSC |        | 0.026 | BSC   |
| Н   | 0.50     | 0.60   | 0.020 | 0.024 |
| J   | 0.09     | 0.20   | 0.004 | 0.008 |
| J1  | 0.09     | 0.16   | 0.004 | 0.006 |
| Κ   | 0.19     | 0.30   | 0.007 | 0.012 |
| K1  | 0.19     | 0.25   | 0.007 | 0.010 |
| L   | 6.40     | BSC    | 0.252 | BSC   |
| М   | 0 °      | 8 °    | 0 °   | 8 °   |

### **SOLDERING FOOTPRINT**



### PACKAGE DIMENSIONS

# SOEIAJ-14 **F SUFFIX** CASE 965-01 **ISSUE B**



### NOTES:

- 1. DIMENO... Y14.5M, 1982. DIMENSIONING AND TOLERANCING PER ANSI
- CONTROLLING DIMENSION: MILLIMETER.
  DIMENSIONS D AND E DO NOT INCLUDE
- MOLD FLASH OR PROTRUSIONS AND ARE MEASURED AT THE PARTING LINE, MOLD FLASH OR PROTRUSIONS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
- TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY. 5. THE LEAD WIDTH DIMENSION (b) DOES NOT
- INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE LEAD WIDTH
  DIMENSION AT MAXIMUM MATERIAL CONDITION. DAMBAR CANNOT BE LOCATED ON THE LOWER
  RADIUS OR THE FOOT. MINIMUM SPACE BETWEEN PROTRUSIONS AND ADJACENT LEAD TO BE 0.46 (0.018).

|                | MILLIN   | ETERS INC |        | HES   |
|----------------|----------|-----------|--------|-------|
| DIM            | MIN      | MAX       | MIN    | MAX   |
| Α              |          | 2.05      |        | 0.081 |
| A <sub>1</sub> | 0.05     | 0.20      | 0.002  | 0.008 |
| b              | 0.35     | 0.50      | 0.014  | 0.020 |
| С              | 0.10     | 0.20      | 0.004  | 0.008 |
| D              | 9.90     | 10.50     | 0.390  | 0.413 |
| Е              | 5.10     | 5.45      | 0.201  | 0.215 |
| е              | 1.27 BSC |           | 0.050  | BSC   |
| HE             | 7.40     | 8.20      | 0.291  | 0.323 |
| L              | 0.50     | 0.85      | 0.020  | 0.033 |
| LE             | 1.10     | 1.50      | 0.043  | 0.059 |
| М              | 0 °      | 10°       | 0° 10° |       |
| $Q_1$          | 0.70     | 0.90      | 0.028  | 0.035 |
| Z              |          | 1.42      |        | 0.056 |

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